

FDP26N40 / FDPF26N40

N-Channel MOSFET

400V, 26A, 0.16Ω

Features

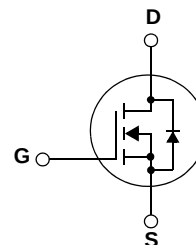
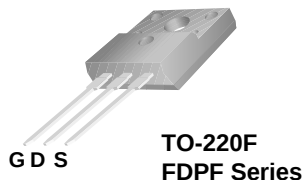
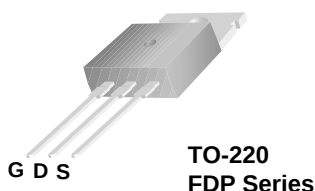
- $R_{DS(on)} = 0.13\Omega$ (Typ.) @ $V_{GS} = 10V$, $I_D = 13A$
- Low gate charge (Typ. 48nC)
- Low C_{RSS} (Typ. 30pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant



Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pluse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted*

Symbol	Parameter	FDP26N40	FDPF26N40	Units
V_{DSS}	Drain to Source Voltage	400		V
V_{GSS}	Gate to Source Voltage	±30		V
I_D	Drain Current	-Continuous ($T_C = 25^\circ\text{C}$)	26	26*
		-Continuous ($T_C = 100^\circ\text{C}$)	15.6	15.6*
I_{DM}	Drain Current	- Pulsed (Note 1)	104	104*
E_{AS}	Single Pulsed Avalanche Energy	(Note 2)	1352	mJ
I_{AR}	Avalanche Current	(Note 1)	26	A
E_{AR}	Repetitive Avalanche Energy	(Note 1)	26.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P_D	Power Dissipation	($T_C = 25^\circ\text{C}$)	265	40
		- Derate above 25°C	2.0	0.3
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150		$^\circ\text{C}$
T_L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds	300		$^\circ\text{C}$

*Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDP26N40	FDPF26N40	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.5	3.0	$^\circ\text{C/W}$
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.5	-	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

Package Marking and Ordering Information $T_C = 25^\circ\text{C}$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP26N40	FDP26N40	TO-220	-	-	50
FDPF26N40	FDPF26N40	TO-220F	-	-	50

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
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Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}$, $V_{GS} = 0\text{V}$, $T_J = 25^\circ\text{C}$	400	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, Referenced to 25°C	-	0.5	-	$V/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 400\text{V}$, $V_{GS} = 0\text{V}$	-	-	1	μA
		$V_{DS} = 320\text{V}$, $T_C = 125^\circ\text{C}$	-	-	10	
I_{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30\text{V}$, $V_{DS} = 0\text{V}$	-	-	± 100	nA

On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu\text{A}$	3.0	-	5.0	V
$R_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{V}$, $I_D = 13\text{A}$	-	0.13	0.16	Ω
g_{FS}	Forward Transconductance	$V_{DS} = 20\text{V}$, $I_D = 13\text{A}$ (Note 4)	-	25.5	-	S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 25\text{V}$, $V_{GS} = 0\text{V}$ $f = 1\text{MHz}$	-	2400	3185	pF
C_{oss}	Output Capacitance		-	390	520	pF
C_{rss}	Reverse Transfer Capacitance		-	30	45	pF
$Q_{g(tot)}$	Total Gate Charge at 10V	$V_{DS} = 320\text{V}$, $I_D = 26\text{A}$ $V_{GS} = 10\text{V}$ (Note 4, 5)	-	48	60	nC
Q_{gs}	Gate to Source Gate Charge		-	15	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	20	-	nC

Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 200\text{V}$, $I_D = 26\text{A}$ $R_G = 25\Omega$ (Note 4, 5)	-	45	100	ns
t_r	Turn-On Rise Time		-	100	210	ns
$t_{d(off)}$	Turn-Off Delay Time		-	115	240	ns
t_f	Turn-Off Fall Time		-	66	140	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	26	A
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	104	A
V _{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _{SD} = 26A	-	-	1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 26A dI _F /dt = 100A/μs (Note 4)	-	406	-	ns
Q _{rr}	Reverse Recovery Charge		-	5.17	-	μC

Notes:

- 1: Repetitive Rating: Pulse width limited by maximum junction temperature
- 2: $L = 4\text{mH}$, $I_{AS} = 26\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$
- 3: $I_{SD} \leq 26\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$
- 4: Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
- 5: Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

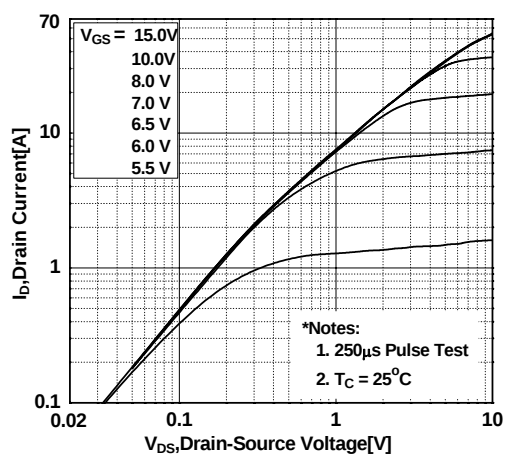


Figure 2. Transfer Characteristics

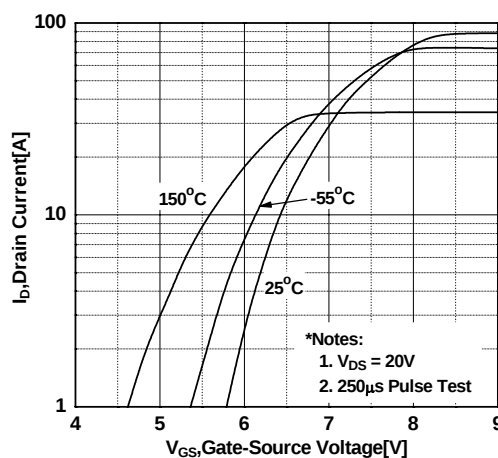


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

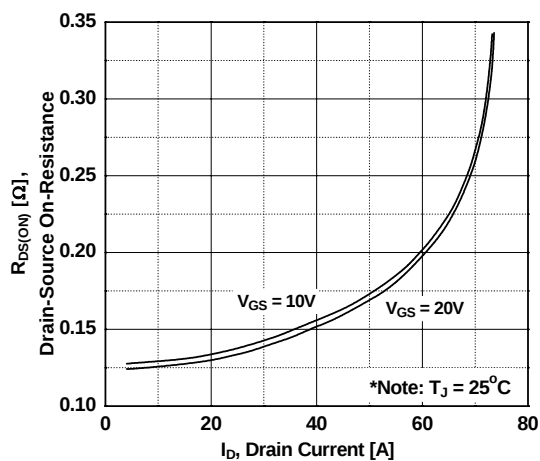


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

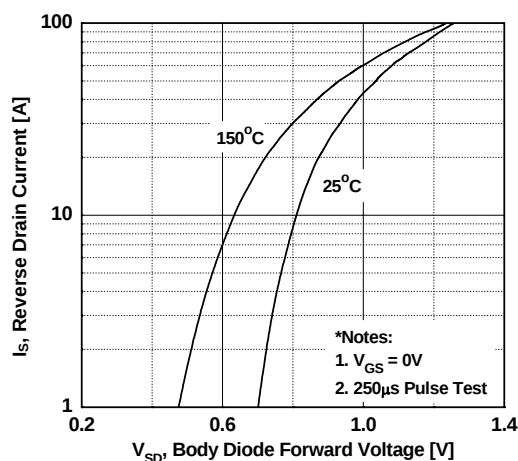


Figure 5. Capacitance Characteristics

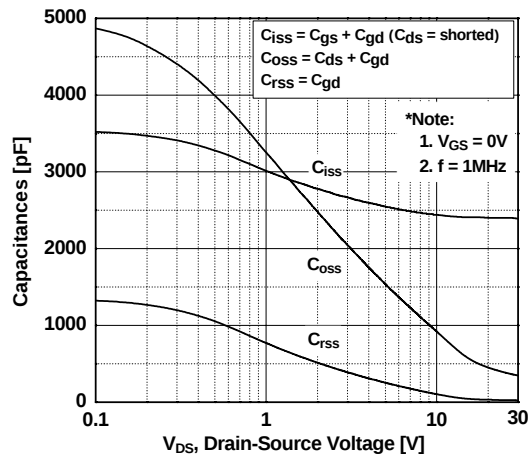
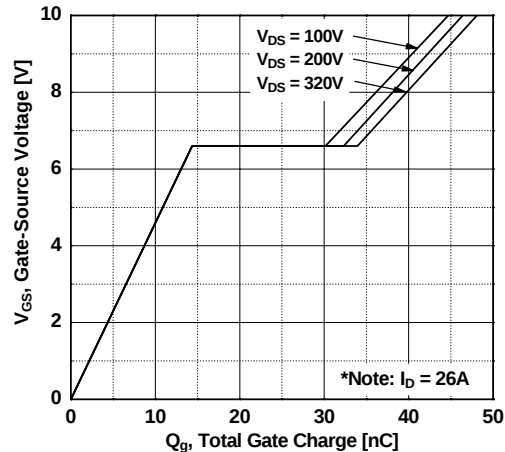


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

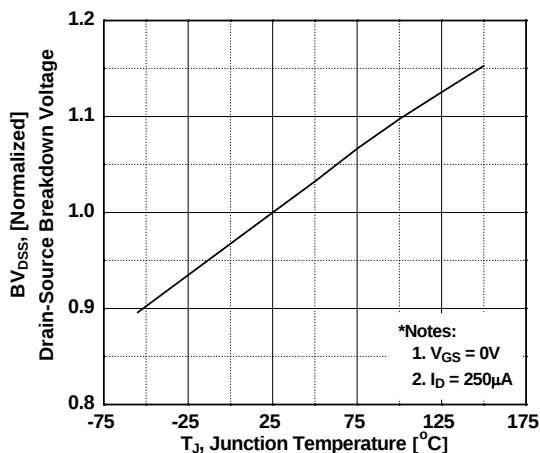


Figure 8. On-Resistance Variation vs. Temperature

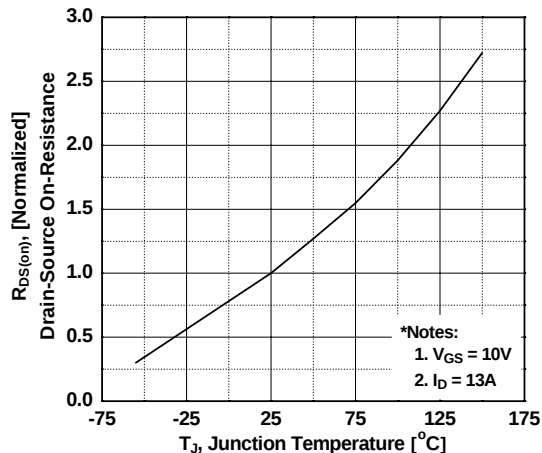


Figure 9. Maximum Safe Operating Area - FDP26N40

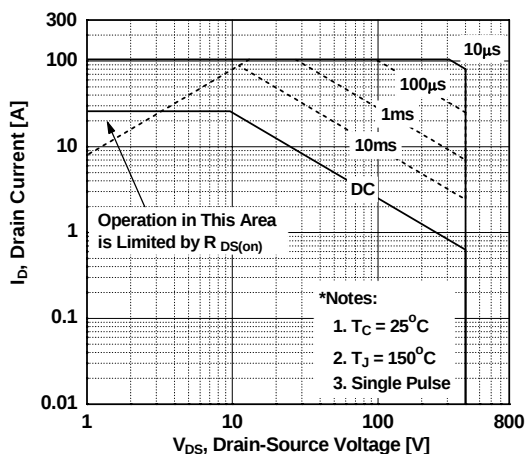


Figure 10. Maximum Safe Operating Area

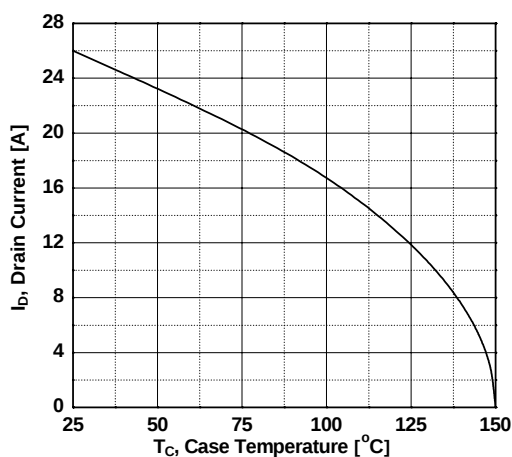
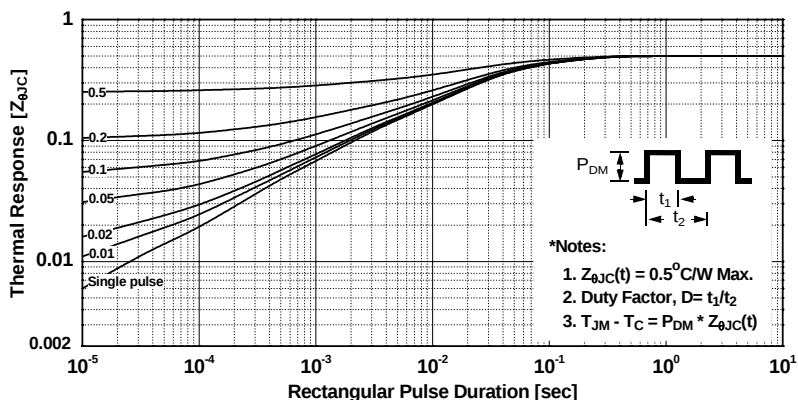
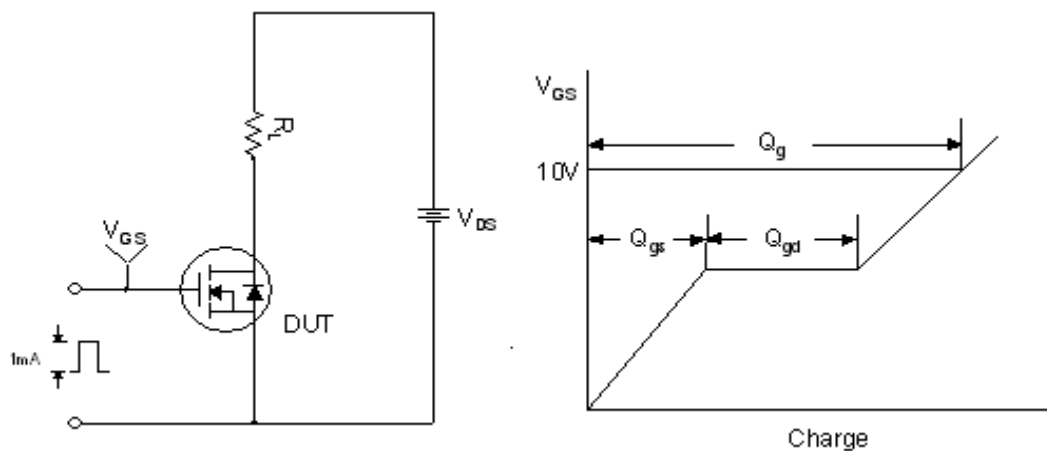


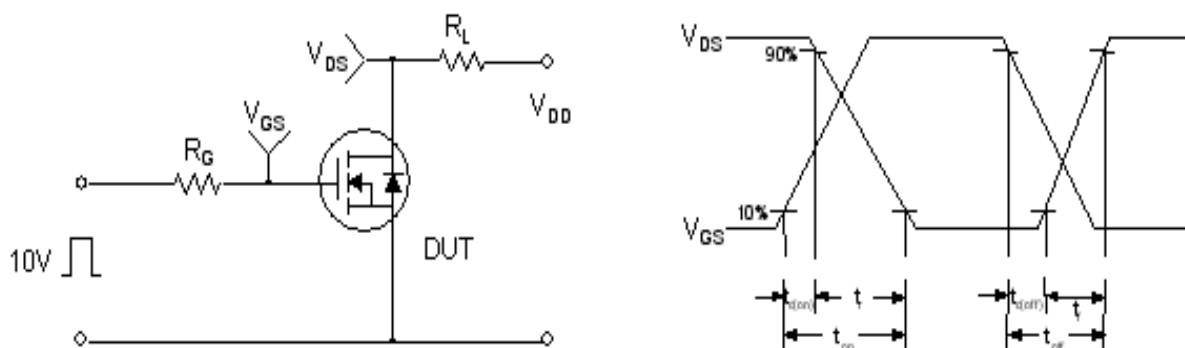
Figure 11. Transient Thermal Response Curve - FDP26N40



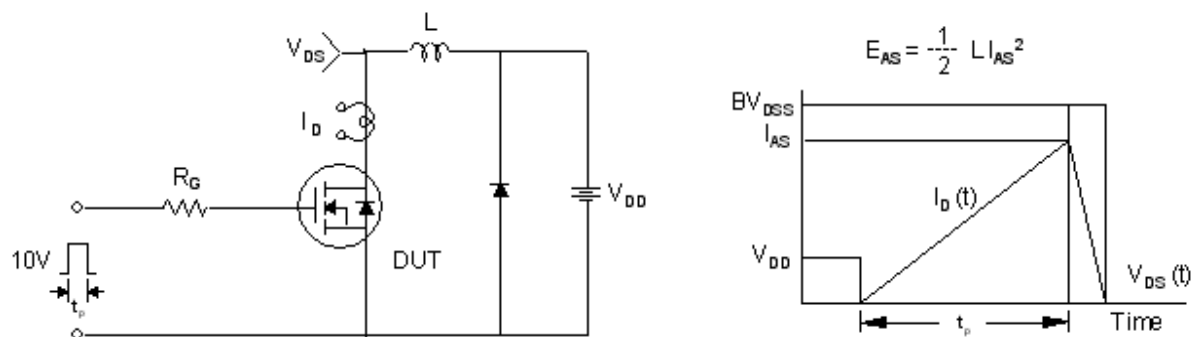
Gate Charge Test Circuit & Waveform



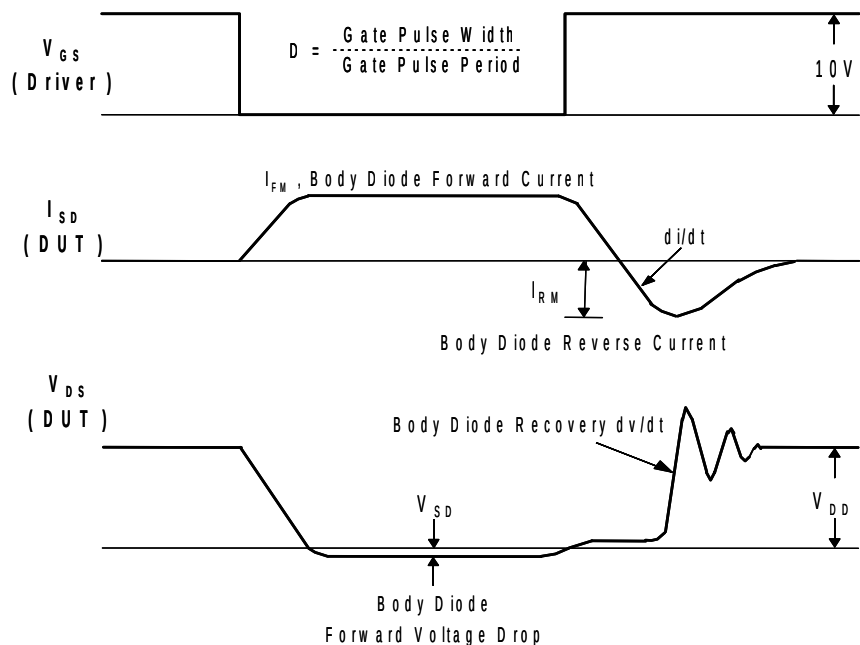
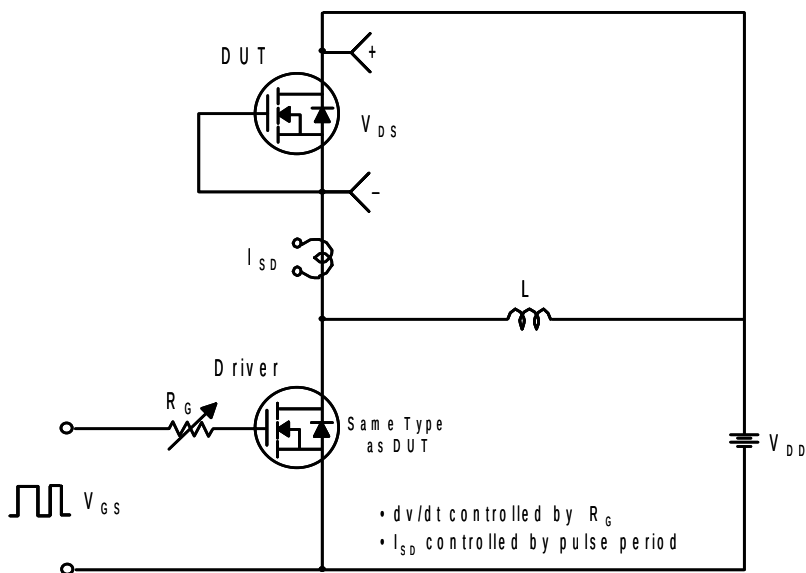
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



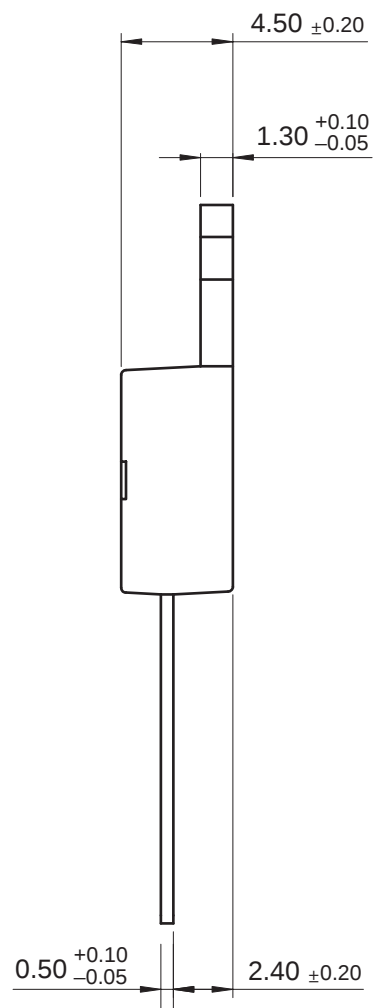
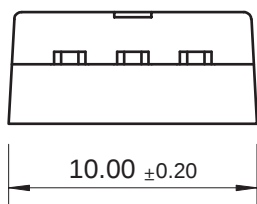
Peak Diode Recovery dv/dt Test Circuit & Waveforms



Technical drawing of a 3-pin connector. The drawing shows a top view and a side view. The top view is a rectangle with a central circular hole and three rectangular pins extending from the bottom. The side view shows the profile of the connector, including the pins and the main body. Dimensions are given in inches (top) and millimeters (bottom). Tolerances are indicated by $\pm$ values. A 45° chamfer is shown on the pins.

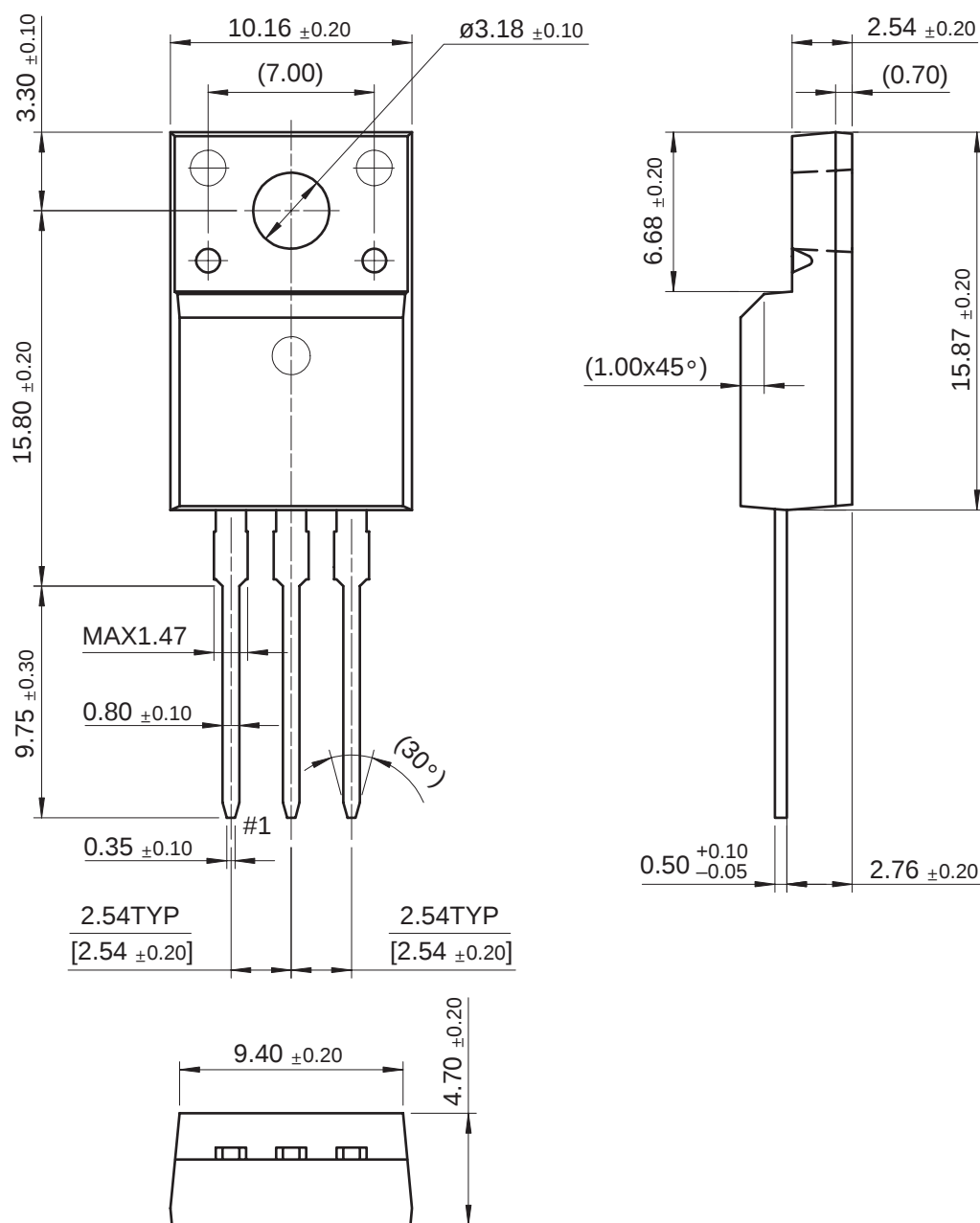
Dimensions (Inches / Millimeters):

- Overall width: 9.90 ± 0.20 / 251.46
- Width of central hole: 8.70 / 221.46
- Width of central hole: $\varnothing 3.60 \pm 0.10$ / 91.40
- Width of left pin: 1.27 ± 0.10 / 32.27
- Width of right pin: 1.52 ± 0.10 / 38.60
- Width of central pin: 0.80 ± 0.10 / 20.32
- Overall height: 18.95 MAX. / 480.35
- Height of main body: 15.90 ± 0.20 / 403.40
- Height of top flange: 2.80 ± 0.10 / 71.12
- Height of bottom flange: 1.30 ± 0.10 / 33.02
- Height of central hole: 1.70 / 43.18
- Height of left pin: 13.08 ± 0.20 / 332.32
- Height of right pin: 10.08 ± 0.30 / 256.51
- Height of central pin: 1.00 / 25.40
- Height of top flange: 1.46 / 37.09
- Height of bottom flange: 3.00 / 76.20
- Height of central hole: 3.70 / 93.98
- Height of central pin: 2.54 TYP / 64.51
- Height of central pin: 2.54 TYP / 64.51
- Height of central pin: 2.54 TYP / 64.51



Mechanical Dimensions

TO-220F



Dimensions in Millimeters



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 ®	MegaBuck™	Quiet Series™	TinyPower™
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